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Quantitative analysis of time-resolved infrared stimulated luminescence in feldspars



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ABSTRACT

Time-resolved infrared-stimulated luminescence (TR-IRSL) from feldspar samples is of importance in the field of luminescence dating, since it provides information on the luminescence mechanism in these materials. In this paper we present new analytical equations which can be used to analyze TR-IRSL signals, both during and after short infrared stimulation pulses. The equations are developed using a recently proposed kinetic model, which describes localized electronic recombination via tunneling between trapped electrons and recombination centers in luminescent materials. Recombination is assumed to take place from the excited state of the trapped electron to the nearest-neighbor center within a random distribution of luminescence recombination centers. Different possibilities are examined within the model, depending on the relative importance of electron de-excitation and recombination. The equations are applied to experimental TR-IRSL data of natural feldspars, and good agreement is found between experimental and modeling results.

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1. Introduction

When an insulating material is exposed to ionizing radiation, some of the free electrons resulting from the interaction will end up being trapped at defects in the crystal. The concentration of such trapped charges is a function of the radiation dose, and this relationship form the basis of trapped-charge dating methods. When the crystal is subsequently exposed to optical excitation, some of the trapped electrons can be released from the traps and recombine, radiatively, with holes trapped at appropriate centers to produce optically stimulated luminescence, which is widely used in sediment dating. In this paper we are concerned with feldspars, for which the excitation spectra of the optically stimulated luminescence have a prominent peak at \sim 1.44 eV [21]. The defects related to this resonance also exhibit tunneling effects associated with a variable tunneling distance. For a summary of previous work on feldspars the reader is referred to the books by Chen and Pagonis [7] and Bøtter-Jensen et al. [6].

During the past decade numerous experimental and modeling studies have established that quantum mechanical tunneling is the

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http://dx.doi.org/10.1016/j.physb.2016.06.013 0921-4526/© 2016 Elsevier B.V. All rights reserved. dominant mechanism for production of luminescence signals in feldspars [12–15,20,23–25,3,35,36,45–47,6]. While many of these studies are concerned with tunneling taking place from the ground state of the trap, research has also supported the existence of tunneling processes taking place from the excited state of the trap, as well as in combination with charge migration through the conduction band-tail states [1,18,2,21,29,42,43].

Jain et al. [17] developed a model in which localized electronic recombination of pairs of trapped electrons and recombination centers takes place via the excited state of the trapped electron, to the nearest center within a random distribution of them. They successfully simulated both thermally stimulated luminescence (TL) and optically/infrared stimulated luminescence (OSL, IRSL), and found that a power law behavior can occur for OSL. This model was examined by Kitis and Pagonis [19], to obtain analytical solutions for four different experimental modes of stimulation: TL, OSL, linearly modulated OSL (LM-OSL) and isothermal TL. These analytical solutions have been used in several recent experimental studies to fit luminescence from a variety of feldspars and apatites [28,31,32,34,39,40].

Time-resolved luminescence data provide a method of distinguishing between the different recombination routes in a variety of materials. Time-resolved optically stimulated and infrared stimulated luminescence (TR-OSL and TR-IRSL) from feldspars have been the subject of several recent experimental studies. Jain and Ankjærgaard [18] compared time resolved luminescence from feldspars using mainly IR, green and blue stimulations and examined the changes occurring as a function of photon energy, storage time after irradiation, and thermal or optical pre-treatments of the samples. These experimental results were interpreted within the framework of a model containing several possible pathways for charge movement, namely from the dosimetric trap via the ground and excited states of the trap, via the band tail states and through the conduction band. Jain and Ankjærgaard [18] concluded that the initial "fast signal" in their TR-IRSL data is most likely due to localized transitions, while the "slow signal" in their data originated in transitions through the band tail state.

Several experimental studies have identified five ranges of lifetimes in TR-IRSL signals, namely 30–50 ns, 300–500 ns, 1–2 μ s, ~5 μ s, and > 10 μ s [10,11,38,44,8,9]. Some of these lifetimes were interpreted as due to internal transitions within the recombination centers [8]. In several of these earlier papers TR-IRSL curves were fitted using a sum of exponentials. Morthekai et al. [26] studied TR-IRSL from four feldspar mineral specimens, by assuming that de-trapped electrons undergo random walk in the band-tail states before recombining by tunneling. The hopping time for the random walk was derived from the OFF-time data of TR-IRSL experiments, and the extracted parameters were shown to be consistent with the variable range hopping mechanism of the Mott kind. Pagonis et al. [30] also analyzed TR-IRSL data from the same four natural feldspars samples, in terms of the sum of an exponential and a stretched exponential function.

The technology of measuring such time-resolved signals has been greatly improved during the past 10 years, and modeling advancements have contributed to a better understanding of the luminescence process. These recent developments in both experiments and models prompted us to re-examine the topic of the shape and mathematical characterization of such signals.

In this paper we use the model of Jain et al. [17] to describe the shape of TR-IRSL signals during and following short infrared pulses.

The goals of the present paper are:

- (1) To investigate whether the model of Jain et al. [17] can be used to describe experimental TR-IRSL data from feldspars, in the microsecond time scale.
- (2) To fit experimental TR-IRSL data from feldspars, both during and after short excitation pulses.
- (3) To examine different outcomes from the model, depending on the values of the various kinetic parameters.

2. Samples and experimental setup

The TR-IRSL signals from two feldspar samples are analyzed in this paper. The first set of TR-IRSL data was previously published by Morthekai et al. [26] on sample FL1, a museum specimen of feldspar. X-ray diffraction analysis indicated that FL1 is a microcline also containing diopside and albite. The ratio of K:Na:Ca was calculated and these values place FL1 in the alkali feldspar series. The samples were crushed gently using an agate mortar and sieved to obtain the 90–150 mm size fraction, which was used without any further chemical treatment. The second sample is the potassium rich feldspar fraction (K-AlSi₃O₈) of a glacio-fluvial sediment from Jameson land, East Greenland with a grain size 106–180 μ m (lab. code 951002FK). A few milligrams of the samples were mounted on stainless steel disks using Silkospray silicone oil.

Measurements were carried out on a Risø TL/OSL-20 reader equipped with an integrated pulsing option to control the IR LEDs, and a Photon Timer attachment to record the TR-IRSL [22]. The IR stimulation was performed with an 870 nm (FWHM 40 nm) LED array delivering 100 mW/cm². The stimulated luminescence emission was detected using a photomultiplier tube (EMI 9235QB; 30% QE at 395 nm), and the time-resolved signals for sample FL1 were detected using a combination of BG-39 (2 mm) and Corning 7–59 (4 mm) filters (transmitting photons at 395 + 50 nm). The TR-IRSL signals for the potassium rich feldspar fraction were detected in the UV emission (U340 filter, 7.5 mm).

For sample FL1 the TR-IRSL signals were measured for a stimulation temperature of 50 °C, after the sample was given a dose of 61.8 Gy, and preheated to 280 °C for 60 s, using an ON–time of 50 μ s and an OFF-time 100 μ s. For sample 951002FK the TR-IRSL curves were measured at a stimulation temperature of 50 °C, after the sample was given a dose of 70 Gy, and then preheated to 250 °C for 60 s, using an ON-time of 500 μ s, and an OFF-time of 300 μ s. The natural luminescence signals were erased by exposing the samples to IR at an elevated temperature of 250 °C, followed by heating the sample from room temperature up to 500 °C. For sample FL1, the total stimulation time was 100 s and hence 95 thousand pulses with a pulse period of 1050 μ s were used. For sample 951002FK the total stimulation time was 10 s.

An important experimental consideration when fitting the TR-IRSL data is the switching-off speed (or the fall-time) of the LEDs. The diode intensity after the end of the excitation period reduces very quickly to ~5% of the initial intensity, but it takes an additional ~3 µs for the IR diodes to reach a light level of less than 1% of the stimulation light level during the pulse. Therefore, for the analysis of the experimental data in this paper, all data points for $t < 3 \mu s$ are not used in the fitting process, since they may represent a mixture of the luminescence signal from the sample and the signal during the LED switching-off.

3. Analysis of time-resolved experiments using the model by Jain et al. [17]

In this section we use the model and notation of Jain et al. [17,16]. The model assumes a random distribution of trapped electrons and a random distribution of nearest-neighbor recombination centers, and that emission of luminescence is a result of tunneling recombination of a trapped electron from the excited state of the trap, excited by optical stimulation. Fig. 1 illustrates the different transitions considered within this model: Optical



Fig. 1. Simplified band diagram showing the feldspar luminescence transitions considered in the model and discussed in the text: Transition (i) denotes the optical transition between the ground state of the trapped electron to the excited state, and transition (ii) is de-excitation back into the ground state. Transition (iii) is direct tunneling from the excited state of the trapped electron to the recombination center. The figure is adapted after Jain and Ankjærgaard [18] and Jain et al. [17,16].

excitation of electrons from the ground state into the excited state of the trap during IR stimulation (transition i). From the excited state, the electrons can either de-excite back into the ground state (transition ii) or tunnel from the excited state to the recombination center (transition iii). The physical assumptions in the model of Jain et al. [17] are summarized in Table 1 of their paper, and includes that the concentration of recombination centers is assumed to be much larger than the concentration of trapped electrons, and that an electron tunnels only to its nearest center. In the exact form of the model presented by Jain et al. [16], the differential equations are:

$$\frac{\partial n_g(r',t)}{\partial t} = -An_g(r',t) + Bn_e(r',t), \tag{1}$$

$$\frac{\partial n_e(r',t)}{\partial t} = An_g(r',t) - Bn_e(r',t) - \frac{n_e(r',t)}{\tau(r')},$$
(2)

$$L(t) \propto \int_0^\infty \frac{n_e(r', t)}{\tau(r')} dr',$$
(3)

$$\tau = b^{-1} \exp\left(\frac{r'}{\left(\rho'\right)^{1/3}}\right) \tag{4}$$

The parameters and symbols used in the model are as follows. As discussed in Jain et al. [17], it is advantageous from a mathematic appoint of view to transform the absolute distance r between the trapped electron and recombination center into a dimensionless distance parameter which is defined by $r' = (4\pi\rho/3)^{1/3}r$, where ρ represents the actual number density of centers in the material; with such a transformation the nearest neighbor distribution becomes independent of the true number density of the centers. Similarly one introduces the dimensionless number density of recombination centers parameter by $\rho' = (4\pi\rho/3)\alpha^{-3}$, where α is the potential barrier penetration constant [15]. By introducing these dimensionless parameters, one can describe the nearest neighbor distribution in the material in a manner that does not depend on the actual number density ρ of centers.

 $n_g(r', t)$ and $n_e(r', t)$ are the instantaneous concentrations of electrons in the ground state and in the excited state correspondingly. These concentrations are functions of time t and of r'. A is the excitation rate from the ground to the excited state (Transition i, Fig. 1) given by $A = \sigma(E)I$. Here E is the optical stimulation photon energy, $\sigma(E)$ is the optical absorption cross-section and I is the photon flux. De-excitation from the excited state back in to the ground state (Transition ii, Fig. 1) is governed by the relaxation rate B, and L(t) is the instantaneous photon emission rate resulting from tunneling recombination via the excited state (Transition iii, Fig. 1). The attempt-to-tunnel frequency is denoted by b in Jain et al. [16] and in Eq. (4) above. In general, there is no physical relationship between the two quantities B, b and these two parameters can have very different numerical values.

3.1. Solution of the differential equations during a short IR excitation pulse

During a TR-IRSL experiment we assume that the excitation pulse is sufficiently short, such that only a small number of electrons are raised from the ground state into the excited state of the trap by IR excitation. Thus, during and after a TR-IRSL pulse, the concentration of electrons in the ground state $n_g(r', t)$ does not change significantly and so one can approximate $n_g(r', t) = n_g(r', 0)$ in Eq. (2), where $n_g(r', 0)$ is the concentration of



Fig. 2. (a) The distribution of electrons $n_e(r', t)$ in the excited state calculated using Eq. (6) and for the set of parameters $\rho' = 0.010$, $n_0 = 10^8 \text{ cm}^{-3}$, $A = 10^3 \text{ s}^{-1}$, $s = 10^8 \text{ s}^{-1}$, $B = 10^5 \text{ s}^{-1}$. As the excitation time increases during the pulse, the distribution $n_e(r', t)$ increases with the excitation time, and also shifts to higher values of the distance r'. At long excitation times $t = 25 \,\mu\text{s}$ the distribution $n_e(r', t)$ starts to approach a saturation/equilibrium value. (b) Example of $L_{ON}(t)$ calculated from Eq. (12) by numerical integration for the same set of parameters as in (a), and for two values of the charge density $\rho' = 0.001$ and $\rho' = 0.010$.

electrons at the beginning of the TR-IRSL experiment. Eq. (2) then yields:

$$\frac{\partial n_e(r',t)}{\partial t} = An_g(r',0) - n_e(r',t) \left[B + \frac{1}{\tau(r')} \right].$$
(5)

The solution is:

$$n_{e}(r', t) = \frac{An_{g}(r', 0)}{B + \frac{1}{\tau(r')}} \left(1 - e^{-\left[B + \frac{1}{\tau(r')}\right]t} \right) \text{ for } 0 < t < t_{o}, \quad (\text{DURING PULSE})$$
(6)

where t_o represents the stimulation pulse length. Thus for a given distance r' the concentration of electrons $n_e(r', t)$ in the excited state will grow during the optical excitation period.

The luminescence intensity $L_{ON}(t)$ during the IR pulse can be found from Eqs. (3) and (6):

$$\begin{split} L_{\rm ON}(t) &\propto \int_0^\infty \frac{n_e(r',t)}{\tau(r')} dr' \\ &= \int_0^\infty \frac{A n_g(r',0)}{1+B \tau(r')} \Biggl(1 - e^{-\left[B + \frac{1}{\tau(r')}\right]t} \Biggr) \quad \text{for } 0 < t < t_o \end{split}$$
(7)



Fig. 3. (a) The distribution of electrons $n_e(r', t)$ in the excited state calculated using Eq. (14) for the charge density $\rho' = 0.010$, and for different times after the stimulating IR light has been turned off. As the time *t* elapses after the end of the pulse, the distribution $n_e(r', t)$ decreases, and shifts to higher values of the distance r'. (b) Example of $L_{OFF}(t)$ calculated by numerical integration of Eq. (16) for the same set of parameters as in Fig. 2.

For a freshly irradiated sample the initial distribution of electrons $n_g(r', 0)$ at the beginning of the experiment is assumed to be given by the probability distribution function:

$$n_g(r', 0) = P(r') = 3n_0(r')^2 \exp\left[-(r')^3\right]$$
(8)

where n_0 is the total initial concentration of trapped electrons. Combining Eqs. (7) and (8) we obtain the desired equation for the luminescence intensity during the excitation period of the pulse:

$$L_{ON}(t) = \int_{0}^{\infty} \frac{3n_{0}A(r')^{2} \exp\left[-(r')^{3}\right]}{1 + B\tau(r')} \left(1 - e^{-\left[B + \frac{1}{\tau(r')}\right]t}\right) dr'$$

for 0 < t < t_ (DURING PULSE) (9)

One can obtain $L_{ON}(t)$ from this equation for any set of parameters n_0 , A, B, b, ρ' , t_0 using numerical integration.

The concentration $n_e(r', t)$ is a function of the distance parameter r', and of the elapsed excitation time t during the excitation pulse. An example of this function calculated from Eq. (6) for the set of parameters $n_0 = 10^8 \text{ cm}^{-3}$, $A = 10^3 \text{ s}^{-1}$, $s = 10^8 \text{ s}^{-1}$, $B = 10^5 \text{ s}^{-1}$, $\rho' = 0.010$ is shown in Fig. 2a. This simulated data shows that as the excitation time t increases during the pulse, the distribution $n_e(r', t)$ also increases with the excitation time t, and shifts to higher values of the distance r'. This result makes physical



Fig. 4. (a)Simulation of several pulses of different excitation periods t_0 , using the same model parameters as in Fig. 2. (b) The decaying part of the pulses in (a) is shown normalized to the start of the decaying period. The duration of the excitation period affects the rate of decay of the pulses.

sense, since one would expect that as the excitation time increases, the pairs with shorter distances have recombined, therefore, the distribution shifts to the higher values r', and more distant pairs may be accessed by the optical excitation process. It is noted that a somewhat similar change in the shape of the distribution of trapped electron-center distances during natural irradiation of feldspars was found in the detailed modeling and experimental study of anomalous fading by Li and Li [25].

Fig. 2b shows an example of the corresponding $L_{ON}(t)$, calculated by numerical integration of Eq. (9). The same set of parameters is used as in Fig. 2a, for two different values of the charge density $\rho' = 0.001$ and $\rho' = 0.010$.

3.2. Solution of the differential equations after the end of the IR excitation pulse

The solution to $n_e(r', t)$ after the end of the infrared stimulation, i.e. when the LED is turned OFF, is obtained by setting A=0 into Eq. (5):

$$\frac{\partial n_e(r',t)}{\partial t} = -n_e(r',t) \left[B + \frac{1}{\tau(r')} \right]$$
(10)

The solution of this equation is a simple decaying exponential of the form:

$$n_e(r', t) = n_e(r', t_o)e^{-\left[B + \frac{1}{\tau(r_o)}\right](t-t_o)} \quad \text{for } t > t_o \quad (\text{AFTER PULSE})$$
(11)

where $n_e(r', t_o)$ represents the concentration $n_e(r', t)$ at the end of the excitation pulse. The value $n_e(r', t_o)$ can be obtained easily from Eq. (6) by setting $t = t_o$. The luminescence intensity $L_{OFF}(t)$ after the end of the IR pulse will be found by combining Eqs. (3) and (11):

$$L_{OFF}(t) = \int_0^\infty \frac{n_e(r', t_o)e^{-\left[B + \frac{1}{\tau(r)}\right]t}}{\tau(r')} dr' \quad \text{for } t > t_o \quad (\text{AFTER PULSE}).$$
(12)

After the end of the excitation pulse the distribution of electrons $n_e(r', t)$ in the excited state is given by Eq. (11) and is shown in Fig. 3a for the charge density $\rho' = 0.010$ and for different times after the stimulating IR light has been turned off. This simulation was carried out using the same set of parameters as in Fig. 2. Note that since $t_o = 25 \,\mu$ s in Fig. 3, the solid curve in Fig. 3a corresponds to the dotted line in Fig. 2a. Fig. 3a shows that as the time elapses after the end of the pulse, the number of electrons $n_e(r', t)$ decreases with the elapsed time t, and the peak shifts to higher values of the distance r' representing more distant - pairs. Fig. 3b shows an example of $L_{OFF}(t)$ calculated from Eq. (12) by numerical integration with the same set of parameters as in Fig. 3a. It is seen from Figs. 2b and 3b, that a lower density causes a slower build up and decay of luminescence, respectively.

Fig. 4a shows the rise of the TR-IRSL signal during the ON-time, and the decay during the OFF-time for a simulation of stimulation pulses with different excitation periods t_o , using the same model parameters as in Fig. 3. Fig. 4b shows the decay after the pulses in Fig. 4a for $t > t_o$, normalized to the start of the decay. An important conclusion from Fig. 4b is that the duration of the excitation period clearly affects the rate of decay and the shape of the pulses after the LED has been turned off; this is because of the progressive shift in the peak of the distribution with the duration of the excitation (Fig. 2a). This is in contrast to the situation with quartz, where the rate of decay of the pulses is independent of the duration of the excitation of the excitation period t_o [27].

3.3. Solution of the differential equations for $B < < 1/\tau$

In the presence of very weak de-excitation (Transition ii, Fig. 1) from the excited state back into the ground state, $B < < 1/\tau$ (or equivalently $B\tau < < 1$), one can approximate $B + 1/\tau$ using $1/\tau$ and Eqs. (6) and (11) become respectively:

$$n_e(r', t) = An_g(r', 0)\tau(r') \left(1 - e^{-\frac{t}{\tau(r')}}\right)$$

for $0 < t < t_o$, (DURING PULSE) (13)

$$n_e(r', t) = n_e(r', t_o)e^{-\frac{t}{\tau(r_o)}} \quad \text{for } t > t_o. \quad (\text{AFTER PULSE})$$
(14)

The luminescence intensity $L_{ON}(t)$ observed during the IR pulse will be found from Eq. (9) which for $B\tau < < 1$ becomes:

$$L_{ON}(t) = \int_0^\infty 3n_0 A r'^2 \exp\left[-(r')^3\right] \left(1 - e^{-t/\tau(r')}\right) dr' \quad \text{for } 0 < t < t_o$$
(15)

By using the normalization property of the probability density function (PDF), $\int_0^\infty 3(r')^2 \exp[-(r')^3] dr' = 1$, Eq. (15) becomes:

$$L_{ON}(t) = n_0 A \left[1 - \int_0^\infty 3 r'^2 \exp\left[-(r')^3 \right] e^{-\frac{t}{\tau(r')}} dr' \right]$$
(16)

The integral appearing in Eq. (16) has been studied previously extensively [15,17,33,41] and can be approximated by the expression $\exp\left[-\rho' \ln (zbt)^3\right]$, where *b* denotes the tunneling frequency, and z = 1.8 is an empirical correction factor which is



Fig. 5. TR-IRSL curve obtained using feldspar sample FL1 described in the text. The signal was measured for a stimulation temperature of 50 °C, after the sample was given a dose of 61.8 Gy, and preheated to 280 °C for 60 s. The experimental data has been normalized to the maximum TR-IRSL intensity reached at the end of the excitation period. (a) Signal measured during IR pulse of 50 μ s duration (b) Signal measured during the relaxation period of 100 μ s, after the IR LEDs have been turned off. The solid lines represent the analytical equations, with the best fitting parameters given in the text.

introduced in order to describe accurately the result of the numerical integration. With this substitution for the integral, one obtains from Eq. (16):

$$L_{ON}(t) = n_0 A \left[1 - \exp\left[-\rho' \ln \left(zbt \right)^3 \right] \right]$$

for 0 < t < t_o (DURING PULSE). (17)

Similarly starting with the approximation $B\tau < < 1$ one obtains from Eq. (12):

$$L_{OFF}(t) = \int_{0}^{\infty} An_{g}(r', 0) e^{-t/\tau(r_{\prime})} dr' - \int_{0}^{\infty} An_{g}(r', 0) \left(e^{-(t+t_{0})/\tau(r_{\prime})} \right) dr'$$
(18)

The integrals in this equation can again be approximated by the expressions $\exp\left[-\rho' \ln (zbt)^3\right]$ and $\exp\left[-\rho' \ln [zb(t + t_o)]^3\right]$ to obtain:

$$L_{OFF}(t) = An_o \left\{ \exp\left[-\rho' \ln\left(zbt\right)^3\right] - \exp\left[-\rho' \ln\left[zb(t+t_o)\right]^3\right] \right\}$$

for $t > t_o \left(AFTER PULSE\right)$ (19)

Summarizing, the analytical Eqs. (17) and (19) can be used to fit the luminescence intensity during and after the IR pulse in a TR-IRSL experiment, and they should be applicable under the condition of weak de-excitation, $B < < 1/\tau$. It must be noted that strictly speaking from a mathematical point of view, the inequality $B < < 1/\tau$ may not be satisfied at very small times and very small radii. This will most likely result in the equations in this section being less accurate at small times near the beginning of the TR-IRSL experiments.

3.4. Solution of the differential equations for $B > > 1/\tau$

In the presence of strong de-excitation (Transition ii, Fig. 1) of electrons in the excited state back into the ground state, $B > > 1/\tau$, one approximates $B + 1/\tau$ with Band Eqs. (6) and (11) become:

$$n_e(r', t) = \frac{An_g(r', 0)}{B} (1 - e^{-Bt}) \quad \text{for } 0 < t < t_o,$$
(20)

$$n_e(r', t) = n_e(r', t_o)e^{-Bt} \quad \text{for } t > t_o.$$
(21)

The luminescence intensity $L_{ON}(t)$ and $L_{OFF}(t)$ will be found from:

$$L_{ON}(t) = \int_0^\infty \frac{n_e(r', t)}{\tau(r')} dr' = \frac{A(1 - e^{-Bt})}{B} \int_0^\infty n_g(r', 0) dr'$$
$$= \frac{An_o}{B} (1 - e^{-Bt}), (\text{DURING PULSE})$$
(22)

$$L_{OFF}(t) = \int_0^\infty \frac{n_e(r', t_o)}{\tau(r')} e^{-Bt} dr' = e^{-Bt} \int_0^\infty \frac{n_e(r', t_o)}{\tau(r')} dr'$$
$$= De^{-Bt} \quad (AFTER PULSE)$$
(23)

where D is a constant which depends on the experimental conditions.

In these cases the characteristic time $\tau = 1/B$ for the luminescence intensity both during and after the pulse is independent of both the density parameter ρ' , and the dimensionless distance parameter r', and therefore the intensity can be described by simple exponential functions. The analytical Eqs. (22) and (23) can be used to fit the luminescence intensity during and after the IR pulse in a TR-IRSL experiment, and they should be applicable under conditions of strong de-excitation, $B > > 1/\tau$.

In the cases where the parameters *B* and $1/\tau$ are approximately of the same order of magnitude, it is not possible to obtain an analytical equation, and the luminescence intensity $L_{ON}(t)$ during the IR pulse must be evaluated by numerically integrating Eqs. (12) and (16).

4. Comparison of analytical equations with experimental data

Previously published quantitative analysis of TR-IRSL data



Fig. 6. TR-IRSL curve obtained using potassium rich feldspar (lab. code 951002 FK). The signal was measured at a stimulation temperature of 50 °C, after the sample was given a dose of 70 Gy, and then preheated to 250 °C for 60 s. (a) Signal measured during IR pulse of 500 μ s duration (b) Signal measured during the relaxation period of 300 μ s, after the IR LEDs have been turned off. The solid lines represent the analytical equations, with the best fitting parameters given in the text.

concerned mainly the emission measured after the excitation has been turned off (see for example [26] and [30]). In this section we present two examples in which *both* parts of the TR-IRSL signal are fitted using the new analytical equations.

As was discussed in detail in Section 2 of this paper, the behavior of the TR-signals may depend on the relative values of the parameters *B* and $1/\tau$. In this section we assume that the TR-IRSL signals are described by the condition $B < < 1/\tau$, since they provide the best fitting to the experimental data. However, the other two possibilities of $B > > 1/\tau$ and $B \sim 1/\tau$ cannot be excluded, and may be prevalent for other types of samples.

Fig. 5a shows the rising part of a TR-IRSL curve during the ON-

time of 50 μ s for the FL1 feldspar sample described in the experimental section. The signal was measured for a stimulation temperature of 50 °C, after the sample was given a dose of 61.8 Gy, and preheated to 280 °C for 60 s. The experimental data has been normalized to the maximum TR-IRSL intensity reached at the end of the excitation period. The analytical equation from the previous section is used to fit the data in Fig. 5a during the IR stimulation pulse of 50 μ s, in the form:

$$L_{ON}(t) = D \left[1 - \exp \left[-\rho' \ln \left(zbt \right)^3 \right] \right] + bgd.$$
(24)

The parameters used to fit the data in Fig. 5a are the charge density ρ' , the tunneling frequency *b*, and the constant background parameter *bgd*. The best fitting parameters are $b = (4.6 \pm 0.1) \times 10^6 \text{ s}^{-1}$, $\rho' = 0.020 \pm 0.001$, and the background was of the order of 1% of the maximum signal.

The fitted line in Fig. 5a and the residuals shown below indicate a robust fit, although they deviate up to ~8% from the data points in the beginning and towards the end of the light excitation pulse. According to Jain and Ankjærgaard [18], the light emitted during the stimulation pulse is dominated by tunneling from the excited state, but has a small (~5%) contribution from another (slower) recombination route, such as phonon assisted migration through the band tail states. As this is not accounted for in the fitting, this could partly explain the deviation of the fit from the data towards the end of the stimulation pulse. The deviation in the initial $t < 5 \,\mu$ s part of the TR-IRSL curve is likely to be caused by $B < < 1/\tau$ not being valid at small times, see Section 3.3. Despite this, the general trend of the TR-IRSL behavior during the light pulse is satisfactorily described by the analytical equations.

Fig. 5b illustrates the data measured following the de-excitation TR-IRSL curve shown in Fig. 5a. The TR-IRSL OFF-time signal in Fig. 5b was fitted using the analytical equation in the previous section in the form:

$$L_{OFF}(t) = D\left\{ \exp\left[-\rho' \ln\left(zbt\right)^3\right] - \exp\left[-\rho' \ln\left[zb(t+t_o)\right]^3\right] \right\} + bgd$$
(25)

The width of the excitation pulse used in the experiment was $t_o = 50 \ \mu$ s. It was found that the de-excitation data in Fig. 5b could be fitted with the *same* parameters ρ' , *b* as in Fig. 5a. The residuals are shown underneath the graph, they are of the order of 6% of the intensity of the TR-IRSL signal, indicating that the curve shape can be described adequately by tunneling behavior. Note that we also here observe a deviation between the fit and the experimental data for $t < 5 \ \mu$ s as in the previous figure.

Fig. 6a and 6b show the rising and decaying part of a TR-IRSL curve for feldspar sample 951002FK which was described in the experimental section. The signal was measured for a stimulation temperature of 50 °C, after the sample was given a dose of 70 Gy, and preheated to 250 °C for 60 s. The analytical equation from the previous section are again used to fit the data in Fig. 6a and 6b with the width of the excitation pulse $t_a = 500 \,\mu\text{s}$.

The best fitting parameters for Fig. 6a were $b = (2.0 \pm 0.1) \times 10^6 \text{ s}^{-1}$ and $\rho' = 0.020 \pm 0.001$ and the background was of the order of 6% of the overall signal. A slightly adjusted value of $b = (2.6 \pm 0.1) \times 10^6 \text{ s}^{-1}$ was obtained for Fig. 6b, with the background of the order of 4% of the overall signal. The residuals are shown underneath the graph, they are of the order of 6% of the intensity of the TR-IRSL signal in Fig. 6a, and of the order of 2% for Fig. 6b.

Since only 2 samples were measured and with very different on/off time conditions, it is difficult to judge whether the difference in the fitted parameter b between the two samples is due to sample material, or whether it was also affected by the measurement conditions.

5. Discussion and conclusions

In this paper it was demonstrated how typical TR-IRSL signals can be analyzed in the microseconds time scale, by using the tunneling model of random defects. The main assumption in the present model is that very few electrons are raised into the excited state during the optical excitation stage.

In practical situations one does not know beforehand whether the TR-IRSL data corresponds to a situation with $B < < 1/\tau$, $B > > 1/\tau$ or to some intermediate situation which requires numerical integration of the equations in this paper. It is therefore suggested that one starts by fitting experimental TR-IRSL data using the two types of analytical equations in this paper for the ON and OFF parts of the signal. Comparison of the quality of the fits between these two initial fitting procedures could help decide whether one is dealing with $B < < 1/\tau$ or with $B > > 1/\tau$. One must note however that there is presently no experimental evidence for single exponential behavior in TR-IRSL signals from feldspars.

It is important to note that there may be some discrepancies when trying to fit the two parts of the TR signal using the same set of model parameters ρ' , b. Such discrepancies between the fitting parameters most likely indicate the presence of a significant contribution from migration through the band tail states prior to recombination, as discussed in Jain and Ankjærgaard [18], Poolton et al. [37], Kars et al. [21]. Pagonis et al. [30] analyzed a series of TR-IRSL signals from 4 feldspar samples using a linear combination of an exponential and a stretched exponential function, with the latter function discussed in Berberan-Santos et al., [4] and Berberan-Santos [5]. The analysis of Pagonis et al. [30] assumed that migration through the band tail states followed by direct recombination will contribute to the relaxation signal, especially at elevated stimulation temperatures. In the model of Jain and Ankjærgaard [18], the authors also concluded that their TR data contained a significant band tail contribution, depending on the stimulation light and the stimulation temperature. It can be expected that as the stimulation temperature is increased, the contribution of the band tail signal in luminescence signal might become more dominant compared to the fast tunneling signal originating from the excited state. One might also expect that if the discrepancy between the data and analytical equations is due to the contributions from the band tail state, then larger residuals would be observed in the later part of the OFF-time in the TR-IRSL signal. The limited accuracy of the experimental data does not allow us to verify this prediction.

An important result from the model described in this paper is that the shape of the relaxation signals after the LEDs have been turned off depends on the duration of the excitation t_o , as shown in Fig. 4b. This is an important prediction from the model that needs to be confirmed experimentally. Additional experiments can be carried out with other photon energies (e.g. blue LEDs and green LEDs), in order to confirm the predictions of the model.

In order to ascertain whether the conclusions drawn from the model apply to other samples and other types of experiments, further experimental work needs to be carried out with different types of thermal and optical treatments of feldspar samples, with different optical stimulation wavelengths, and with different lengths of the excitation pulses,

It is noted that in time-resolved experiments one typical adds thousands of short pulses, in order to construct the time-resolved signals presented in the figures of this paper. It is therefore important to know to which extent the concentration of electrons in the traps decreases during the complete experimental procedure. In these type of experiments, it is estimated that the trap is typically depleted by only 5–10% over the whole duration of the experiment. We therefore feel that the model presented here will be applicable mainly for the pulses measured during the beginning of the experiment, and that the agreement between model and experiment will become more questionable for the later stages of time-resolved experiments which last more than a few seconds.

An additional important conclusion from the experimental data analyzed in Figs. 5 and 6 is the low value of the tunneling frequency factor $b\sim10^6$ s⁻¹. Jain et al. [16] showed that analysis of their CW-IRSL data yields also a value of $b\sim10^6$ s⁻¹, similar to the low value obtained in the time-resolved experiments described in this paper.

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